

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10576899	PAILA ET AL.
Examiner	Art Unit	
MARCOS BATISTA	2617	

SEARCHED

Class	Subclass	Date	Examiner
370	329	5/13/2008	mb
370	314	5/13/2008	mb
455	343.1-343.4	12/2/2008	mb
713	300, 323, 320, 324	12/2/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with TA - Yogesh Aggarwal	5/13/2008	mb
Consulted with Lun-Yi Lao	5/13/2008	mb
East Search	5/13/2008	mb
Inventor's Name Search	5/13/2008	mb
East Search	12/2/2008	mb
Consulted with Rafael Perez Gutierrez	12/2/2008	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner